
**Fine ceramics (advanced ceramics,
advanced technical ceramics) —
Measurement of Seebeck coefficient
and electrical conductivity of bulk-
type thermoelectric materials at room
and high temperatures**

*Céramiques techniques — Mesurage du coefficient de Seebeck et de
la conductivité électrique de matériaux thermoélectriques en vrac à
température ambiante et à haute température*



COPYRIGHT PROTECTED DOCUMENT

© ISO 2023

All rights reserved. Unless otherwise specified, or required in the context of its implementation, no part of this publication may be reproduced or utilized otherwise in any form or by any means, electronic or mechanical, including photocopying, or posting on the internet or an intranet, without prior written permission. Permission can be requested from either ISO at the address below or ISO's member body in the country of the requester.

ISO copyright office
CP 401 • Ch. de Blandonnet 8
CH-1214 Vernier, Geneva
Phone: +41 22 749 01 11
Email: copyright@iso.org
Website: www.iso.org

Published in Switzerland

Contents

Page

Foreword.....	iv
1 Scope.....	1
2 Normative references.....	1
3 Terms and definitions.....	1
4 Principle.....	2
5 Significance and use.....	4
6 Apparatus.....	4
7 Sampling.....	5
7.1 Shape and dimension of specimen.....	5
7.2 Pre-treatment.....	6
7.3 Storage.....	6
7.4 Number of specimens.....	6
8 Procedure.....	6
8.1 Dimension measurement of specimen.....	6
8.2 Placement of specimen.....	6
8.3 Evacuating and purging the chamber.....	7
8.4 Measurement of electrical conductivity.....	7
8.5 Measurement of Seebeck coefficient.....	7
9 Calculation.....	7
9.1 Seebeck coefficient.....	7
9.2 Electrical conductivity.....	9
10 Expression of results.....	10
10.1 Seebeck coefficient and electrical conductivity.....	10
10.2 Variation of Seebeck coefficient as a function of temperature.....	11
10.3 Variation of electrical conductivity as a function of temperature.....	11
11 Test report.....	12
Annex A (informative) Interlaboratory evaluation of Seebeck coefficient and electrical conductivity of bulk-type thermoelectric materials.....	14
Annex B (informative) Periodic check of the apparatus (or equipment) by using a certified reference material (CRM) or a reference material (RM).....	20
Bibliography.....	21

Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see www.iso.org/patents).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation on the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT) see the following URL: www.iso.org/iso/foreword.html.

This document was prepared by Technical Committee ISO/TC 206, *Fine ceramics*.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at www.iso.org/members.html.

Fine ceramics (advanced ceramics, advanced technical ceramics) — Measurement of Seebeck coefficient and electrical conductivity of bulk-type thermoelectric materials at room and high temperatures

1 Scope

This document specifies the measurement methods for the electronic transport properties of bulk-type thermoelectric materials at room and elevated temperatures. The measurement methods cover the simultaneous determination of Seebeck coefficient and electrical conductivity of bulk-type thermoelectric materials in a temperature range from 300 K to 1 200 K. The measurement methods are applicable to bulk-type thermoelectric materials used for power generation, energy harvesting, cooling and heating, among other things.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO/IEC 17025, *General requirements for the competence of testing and calibration laboratories*

ISO 23331, *Fine ceramics (advanced ceramics, advanced technical ceramics) — Test method for total electrical conductivity of conductive fine ceramics*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminology databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at <https://www.iso.org/obp>
- IEC Electropedia: available at <https://www.electropedia.org/>

3.1

thermoelectric figure of merit

zT

dimensionless factor representing the thermoelectric conversion efficiency of a given material

3.2

thermoelectric power factor

$S^2\sigma$

characteristic value of a thermoelectric material given by the product of the square of Seebeck coefficient (S) and electrical conductivity (σ)

Note 1 to entry: The units of the thermoelectric power factor are watts per metre per square kelvin (W/mK²).

3.3

Seebeck coefficient S

intrinsic property which describes the induced voltage (thermal electromotive force, E) from a given temperature difference (ΔT) in a material

Note 1 to entry: The units of the Seebeck coefficient are microvolts per kelvin ($\mu\text{V/K}$).

3.4

electrical conductivity σ

ability of a material to allow the transport of electric charges

Note 1 to entry: The units of electrical conductivity are Siemens per centimetre (S/cm).

4 Principle

This document is for simultaneously measuring the Seebeck coefficient and the electrical conductivity of bulk-type thermoelectric materials using one measurement system. The off-axis four-terminal method can be used to simultaneously measure the Seebeck coefficient and the electrical conductivity of bulk-type thermoelectric material using one measurement system. As shown in [Figure 1](#), the specimen is set between two metal blocks in the heating zone and two thermocouple probes separately contact the surface of the specimen. The measurement of the Seebeck coefficient of a bulk-type thermoelectric material is necessary to measure the temperature difference between two positions (point H and point C) on a specimen and the voltage across the two same positions ([Figure 1](#)). Seebeck coefficient can be calculated by following [Formula \(1\)](#):

$$S = E / \Delta T \quad (1)$$

where

E is the induced thermoelectric voltage (thermal electromotive force) between the point H and point C of the specimen;

ΔT is the temperature difference between the point H and point C ($= T_H - T_C$).

For Seebeck coefficient measurement, measured temperature is the average temperature of the hot- and cold-side thermocouple probes.

By using the measuring system illustrated in [Figure 2](#), electrical conductivity is also measured based on the four-terminal method. This method is conducted by placing four probes. Constant current is applied through the two outmost probes, causing a measurable voltage drop, V , between the two inner probes. The electrical resistance, R , is calculated using Ohm's law following [Formula \(2\)](#):

$$R = V / I \quad (2)$$

where

V is the voltage;

I is the current.

The resistivity, ρ , is be calculated following [Formula \(3\)](#):

$$\rho = RA / l \quad (3)$$